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- Compare Two 8-Bit Words
- Choice of Totem-Pole or Open-Collector Outputs
- SN74ALS518 and 'ALS520 Have 20-kΩ
 Pullup Resistors on Q Inputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

TYPE	INPUT PULLUP RESISTOR	OUTPUT FUNCTION AND CONFIGURATION
SN74ALS518	Yes	P = Q open collector
'ALS520	Yes	P = Q totem pole
SN74ALS521 [‡]	No	P = Q totem pole

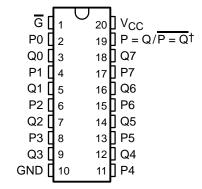
[‡]SN74ALS521 is identical to 'ALS688.

description

These identity comparators perform comparisons on two 8-bit binary or BCD words. The SN74ALS518 provides P = Q outputs, while the 'ALS520 and SN74ALS521 provide $\overline{P}=\overline{Q}$ outputs. The SN74ALS518 has an open-collector output. The SN74ALS518 and 'ALS520 feature 20-k Ω pullup resistors on the Q inputs for analog or switch data.

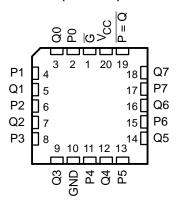
The SN54ALS520 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS518, SN74ALS520, and SN74ALS521 are characterized for operation from 0°C to 70°C.

SN54ALS520 . . . J PACKAGE SN74ALS518, SN74ALS520, SN74ALS521 . . . DW OR N PACKAGE (TOP VIEW)



 † P = Q for SN74ALS518 P = Q for 'ALS520 and SN74ALS521

SN54ALS520 . . . FK PACKAGE (TOP VIEW)



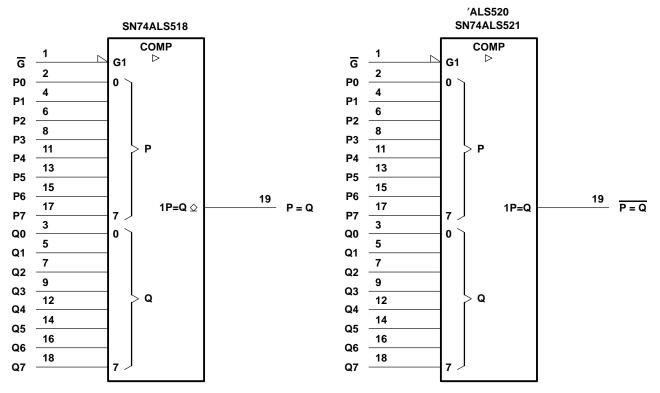
FUNCTION TABLE

IN	PUTS	OUTPUTS			
DATA P, Q	ENABLE G	P = Q	P = Q		
P = Q	L	Н	L		
P > Q	L	L	Н		
P < Q	L	L	Н		
Х	Н	L	Н		

SN54ALS520, SN74ALS518, SN74ALS520, SN74ALS521 8-BIT IDENTITY COMPARATORS

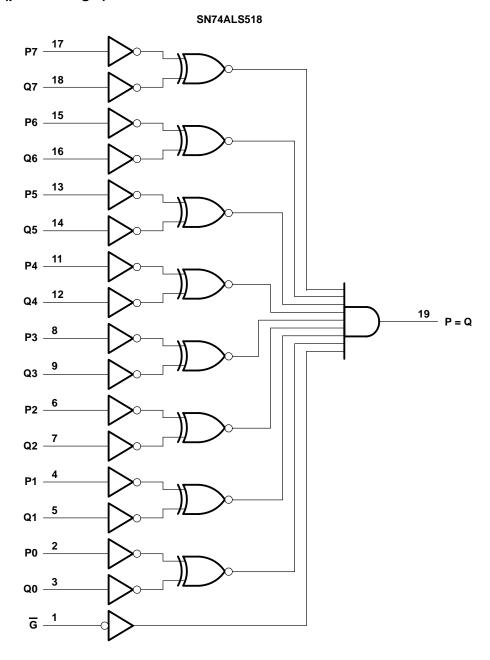
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logic symbols†

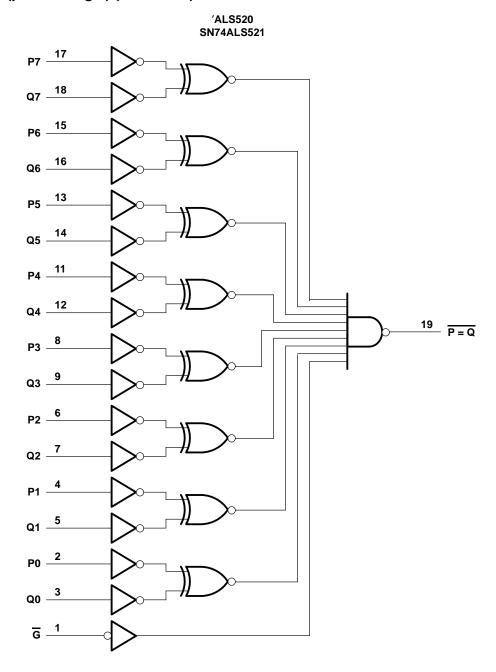


† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagrams (positive logic)



logic diagrams (positive logic) (continued)





SN54ALS520, SN74ALS518, SN74ALS520, SN74ALS521 8-BIT IDENTITY COMPARATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC}	7 V
Input voltage, V _I : Q inputs	V _{CC} + 0.5 V or 5.5 V, whichever is less
All other inputs	7 V
Off-state output voltage	
Operating free-air temperature range, T _A : SN74ALS518	0°C to 70°C
Storage temperature range	

recommended operating conditions

		SN74ALS518		18	UNIT
		MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
Vон	High-level output voltage			5.5	V
loL	Low-level output current			24	mA
TA	Operating free-air temperature	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED		TEST CONDITIONS			SN74ALS518		
	PARAMETER	TEST CON	MIN	TYP‡	MAX	UNIT	
VIK		$V_{CC} = 4.5 V$,	I _I = -18 mA			-1.5	V
loh		V _{CC} = 5.5 V,	V _{OH} = 5.5 V			0.1	mA
V		V 45V	I _{OL} = 12 mA		0.25	0.4	V
VOL		V _{CC} = 4.5 V	I _{OL} = 24 mA		0.35	0.5	V
I.	Q inputs	V 55V	V _I = 5.5 V			0.1 mA	mΛ
ii .	All other inputs	$V_{CC} = 5.5 V$	V _I = 7 V				IIIA
	Q inputs	V 55V	V: 07V			-0.2	mA
lН	All other inputs	$V_{CC} = 5.5 V,$	V _I =27.7′ v			20	μΑ
IIL	Q inputs	V 55V	V. 04b/v			-0.6	A
	All other inputs	$V_{CC} = 5.5 \text{ V},$	۷۱ = €			-0.1	mA
Icc		$V_{CC} = 5.5 V,$	See Note 1		11	17	mA

‡ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25 \text{ °C}$.

NOTE 1: ICC is measured with G grounded, and P and Q at 4.5 V.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

SN54ALS520, SN74ALS518, SN74ALS520, SN74ALS521 8-BIT IDENTITY COMPARATORS

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 4.5 C _L = 50 pF R _L = 680 Ω T _A = MIN t SN74A MIN	o MAX†	UNIT
^t PLH	D - 11 O	Б. О	15	33	
t _{PHL}	P or Q	P = Q	3	15	ns
t _{PLH}	G	P = Q	15	33	ns
t _{PHL}	3	, - Q	3	15	115

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I : Q inputs of 'ALS520 V _{CC} + 0.5 V or 5.5 V, wh	nichever is less
All other inputs	7 V
Operating free-air temperature range, T _A : SN54ALS520 –	55°C to 125°C
SN74ALS520, SN74ALS521	. 0°C to 70°C
Storage temperature range –	65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54ALS520		SN74ALS520 SN74ALS521			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
ЮН	High-level output current			-1			-2.6	mA
loL	Low-level output current			12			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN	SN54ALS520			SN74ALS520 SN74ALS521		
				MIN	TYP [†]	MAX	MIN	TYP [†]	MAX	
٧ıK		V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1.5			-1.5	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2)		V _{CC} -2			
VOH		V45V	I _{OH} = – 1 mA	2.4	3.3					V
		V _{CC} = 4.5 V	$I_{OH} = -2.6 \text{ mA}$				2.4	3.2		
V		Vac 45V	I _{OL} = 12 mA		0.25	0.4		0.25	0.4	V
VOL		V _{CC} = 4.5 V	I _{OL} = 24 mA					0.35	0.5	
	'ALS520 Q inputs	Vac EEV	V _I = 5.5 V			0.1			0.1	mA
11	All other inputs	VCC = 5.5 V	V _I = 7 V			0.1			0.1	mA
	'ALS520 Q inputs	V 55V	V. 27V.			-0.2			-0.2	mA
ΊΗ	All other inputs	V _{CC} = 5.5 V,	V _I =27.4′ v			20			20	μΑ
	'ALS520 Q inputs	Vac EEV	V. 04W.			-0.6			-0.6	A
I _{IL}	All other inputs	V _{CC} = 5.5 V,	VI =℃:\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\			-0.1			-0.1	mA
10 [‡]		V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA
	'ALS520	V 55V	Coo Note 4		12	19		12	19	A
ICC	SN74ALS521	V _{CC} = 5.5 V,	See Note 1		12	19		12	19	mA

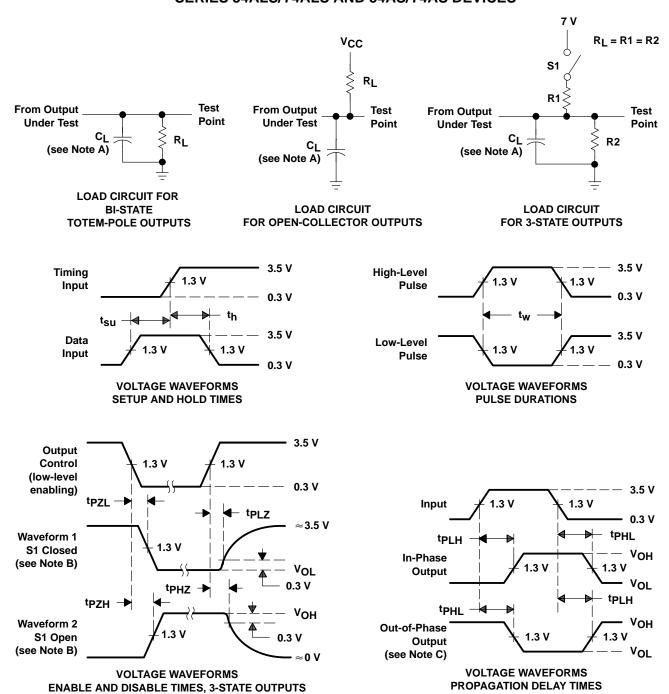
switching characteristics (see Figure 1)

PARAMETER	FROM	TO	V _C C _L R _L T _A	UNIT			
	(INPUT)	(ОИТРИТ)	SN54ALS520		SN74ALS SN74ALS		
			MIN	MAX	MIN	MAX	
^t PLH	D and	<u>P = Q</u>	3	19	3	12	ns
^t PHL	P or Q	P=Q	3	25	5	20	115
^t PLH	G	P = Q	2	18	2	12	ns
tPHL t	Š	1 – Q	5	23	5	22	113

[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, los. NOTE 1: I_{CC} is measured with \overline{G} grounded, and P and Q at 4.5 V.

PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: PRR \leq 1 MHz, $t_f = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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